

**STRUCTURAL AND OPTICAL PROPERTIES OF ELECTROCHEMICALLY
FABRICATED TiO₂ THIN FILMS****Sh.O. EMINOV, Kh.D. JALILOVA, S.A. ALIYEV, N.N. MUSAYEVA, A.A. RAJABLI,
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Several key aspects of the self-organization of nanotubes in RF sputtered titanium (Ti) thin films formed by the anodization process has been investigated. Fabrication procedures included radiofrequency magnetron deposition of InSnO₂ (*ITO*) thin film and Ti thin films on transparent glass wafer followed with electrochemical anodization of Ti in fluorine and aqueous-containing electrolytes. Finally, the obtained Glass/*ITO*/TiO₂ structures were annealed at 450°C for 2h in the air to convert the amorphous both as-anodized TiO₂ and *ITO* into crystalline ones. The observation of surface morphology for TiO₂ films carried out using both atomic force microscopy operating in contact mode and by scanning electron microscope. The structural properties of the samples were characterized by using X-ray diffractometry. The optical properties were studied by using spectroscopic ellipsometry, *UV-VIS* spectrophotometry, as well as Raman spectroscopy. Highly ordered *TNT* arrays of 40-45nm pore diameter with a high degree of optical transmission were obtained. It has been established that, anodization time has an effect on the surface morphology and regularity of the pores. The longer the anodization time, the more regular are the porous structure. *XRD* pattern of the TiO₂ /*ITO* structure has shown the existence of the anatase phase of polycrystalline TiO₂. Polyform phases of rutile and brookite weren't revealed. The films are transparent in the region of 900-360nm with a transmittance of about 70–80% of light and exhibit strong absorption in the *UV* region with a wavelength shorter than 360nm. The Raman spectra confirm the presence of most of the modes directly typical only of the anatase phase and exclude the presence of rutile and brookite phases. Ellipsometry studies allowed it to create an optical model of experimentally obtained glass/*ITO*/TiO₂ structure consisting of five layers with different thicknesses and constituents.

Keywords: *TNT*, TiO₂; InSnO₂, *ITO*, magnetron sputtering, anodic oxidation, TiO₂ nanotube

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1. INTRODUCTION

The development of metal oxide thin films of controlled surface roughness and complexity presents a significant theoretical and technological importance, offering an exciting opportunity for developing a new class of materials with unique physical, chemical, optical and electronic properties [1-7]. Owing to their advanced physical and chemical properties and potential applications in the field of solar energy collection, bio nano- and gas sensors, catalysts, etc., a self-organized, highly ordered array of cylindrical shaped titanium dioxide (TiO₂ or titania) thin films have recently attracted a particularly increased attention because of their extended use in a multitude of applications.

This material is a non-toxic and biocompatible wide-bandgap (3.2–3.30eV) *n*-type semiconductor with extremely high resistivity. It can exist in three main polymorphs: namely anatase, rutile, and brookite.

The first two of them exhibit a tetragonal crystal structure, whereas the third of them (brookite) has an orthorhombic crystal structure. TiO₂ is one of the most desired photocatalysts for environmental and renewable energy applications.

Nanotube arrays of TiO₂ (*TNT*) have many excellent properties such as specific surface area, high adsorption capacity, and so on. They are being applied to many fields, such as environmental applications including the purification of wastewater, hydrogen generation by water splitting, solar photovoltaic based electricity production, gas sensor, and so on [1-12]. In

[12] it has been stated that this better catalytic activity of TiO₂/*ITO* samples is related to a perfect crystalline structure, preventing the recombination of charge carriers.

Because TiO₂ films have a high refractive index and demonstrate high photocatalytic activity, they are usually placed directly onto the top of transparent conductive indium tin oxide (*ITO*) films [14,15]. The ability to control the properties of *TNT* layers formed on transparent and conductive substrates is the key to practical applications in various fields.

Many techniques have been used to prepare TiO₂ films [8-12], such as reactive magnetron sputtering chemical vapor deposition, pulsed laser deposition, sol-gel deposition), and reactive sputtering and anodic oxidation.

The anodic oxidation technique has emerged as one of the most promising techniques. Since the first decades of the 20th century, this electrochemical process has been intensively used for a broad range of industrial applications, including surface finishing, automobile engineering, machinery, corrosion protection, and so on.

The use of electron microscopes in the 1950s revealed the nanoporous and nanotubular structure of anodic oxides and made it possible to establish the effect of the different fabrication parameters on the physical and chemical properties of the prepared structures.

In this work, we present the results of investigations on processing and nanostructural characteristics of TiO₂ porous thin films grown on the transparent glass substrates using magnetron sputtering

techniques, electrochemical anodization, as well as thermal annealing.

2. EXPERIMENTAL

2.1. Preparation of Glass/ITO/TiO₂ structure

The glass substrates were cut into 1.5 by 2 cm pieces and then ultrasonically cleaned in acetone and methanol, rinsed in double-distilled water sequentially, and blow-dried with a nitrogen gun. Afterward, the glass substrates were loaded into the deposition chamber of the Leybold Heraeus-Z550 RF magnetron sputtering system. Then, ITO films with thicknesses varying from 80 to 400 nm were sputtered on them at room temperature in a mixed Argon /O₂ gases mixture using an ITO target (In₂O₃/SnO₂, 90/10 wt.%) [14]. Thereafter, the Titanium layer with a thickness in the range of 150 to 200 nm was sputtered on previously obtained glass/ITO substrates in the same chamber using the titan target. Then, TiO₂ thin film was formed by electrochemical anodization of as-grown Ti film in a homemade two-electrode cell using a Pt mesh as a counter electrode and Ti/ITO/glass substrate as anode under a constant potential ranging from 10 to 60V at 3–5°C. The mixture of ethylene glycol, 0.4wt % ammonium fluoride, and 2 vol.% distilled water was used as an electrolyte. The duration of anodization ranged from a few minutes to several tens of minutes, depending upon the thickness of the Ti layer. To maintain the set temperature during the anodization process, the electrochemical cell was kept in a container with icy water. The samples were removed from the electrolyte after they became optically transparent, and the value of the anodization current dropped to zero. The anodized samples were washed in isopropyl alcohol and distilled water for about 5 min and blow-dried with nitrogen. The obtained glass/ITO/TiO₂ structures finally were annealed for 2 h in the air at 450°C to improve the crystallinity and electrical

characteristics of both external TiO₂ and the internal ITO thin film.

2.2. Characterization Techniques

Supra TM35vp Scanner electron microscope, as well as AFM, was used to investigate the surface morphology of the samples. X-ray diffraction patterns were obtained using an X-Ray D2Phaser (Bruker) diffractometer (Cu-K α ($\lambda=1.54021\text{\AA}$)). The UV-Vis optical transmittance spectrum was recorded by using a Specord-210 spectrophotometer in the range 300–900nm. A Nanofinder 30-NM01 Confocal Raman microscope with an excitation 633nm laser was used to study the vibrational properties of the samples. To study the microstructure characteristics of the films, the J.A. Woollam-M2000 (USA) spectroscopic ellipsometer was used for variable angle spectroscopic ellipsometry (VASE) measurements at room temperature in the photon energy range 0.73–4.0eV at an incident angle of 75°.

3. RESULTS AND DISCUSSION

3.1 Structural properties

Figure 1 shows the XRD pattern of glass/ITO/TiO₂ thin film. The diffractogram shows reflections of the anatase TiO₂ with a predominant (101) peak (at $2\theta=25.5^\circ$) and cubic In₂O₃ ITO thin film. It can be seen that the pattern seems to be anatase. In fact, under these specific preparation conditions, the films are comprised of single anatase. The presence of the anatase polyform phase of TiO₂ with a tetragonal structure ($a=3.799\text{\AA}$, $c=9.509\text{\AA}$; $Z=4$) is confirmed by strong diffraction peaks at $2\theta=25.5, 37^\circ, 48^\circ, 54.1^\circ, 62.5^\circ$ and 67° . These peaks appear as reflections from (101), (004), (200), (105), (204) and (116) planes of anatase, respectively, and match well with the JCPDS file no PDF 03-065-5714. No trace of rutile and brookite phases was detected in the XRD pattern.

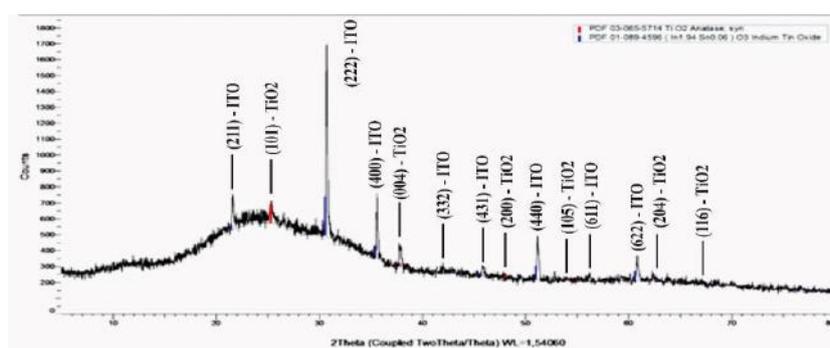


Fig. 1. XRD patterns of the Glass/ITO/TiO₂ structure

3.2. Morphological properties

The atomic forces microscopy (AFM) of the TiO₂ film is shown in figure 2. Nanotubes are clearly visible on the image - they are marked with arrows.

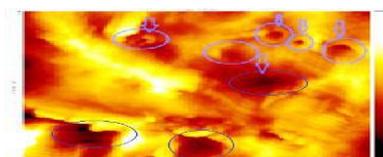


Fig. 2. AFM top view images of TiO₂ surface

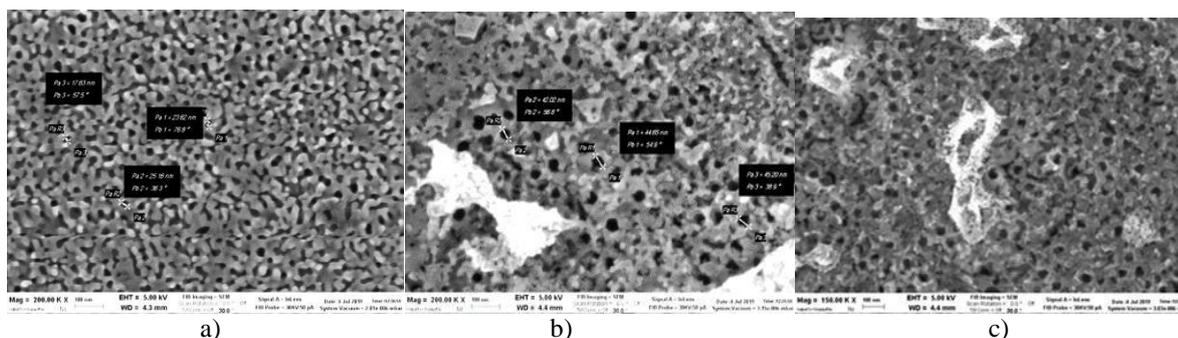


Fig. 3. SEM images of TiO₂ surface after different anodizing time a) 10 min.; b) 20 min.; c) 30 min

Figure 3 (a,b,c) shows SEM images of the surface of the grown films as a function of variation of the anodization time. SEM images of the samples obtained as a result of anodization for 10 minutes are given in figure 3a, whereas the images of the surface obtained as a result of anodization for 20 minutes and 30 minutes are given in figures 3b and 3c respectively.

All images show grain growth indicating crystallization, revealing that the TiO₂ nanotube arrays retained their nanotubular morphologies. Nevertheless, it can be seen from figure 3 that, the morphology and pore sizes of TiO₂ films obtained after different anodization durations are somewhat different and depend on the anodizing time. At the initial stage of anodization (10 min., figure 3a), the pores of different diameters of 17–24 nm were observed only, but nanotubes are not yet visible. After 20 minutes of anodizing (figure 3b), a nanotubular structure with a diameter of about 40 nm appears. After 30 min. of anodizing (figure 3c), this structure appears even more clearly. The following should also be noted: typically, RF magnetron deposited titanium thin film coating is composed of randomly oriented trapezoidal platelets on top of each other with dimensions of 100–1000 nm located at some angles relative to each other [9]. The rate of anodization of these platelets varies. With short-term anodizing, part of the tile does not get enough time to be completely anodized, and additional time is required for this. As a result, a more uniform morphology is observed. Therefore, on the SEM image of the film obtained as a result of anodization for 10 and 20 min., against the background of the holes-mouths of the nanotubes, stand-alone platelets with sides of 50–100 nm length are observed. The surface of the film obtained by anodizing for 30 minutes has a relatively high uniformity.

3.3. Raman spectroscopy

The Raman spectrum of the structure is given in figure 4. Here, arrows of black, green, and red colors are used to indicate the bands of TiO₂, ITO, and glass, respectively. The observed frequencies of the Raman bands of TiO₂ are 143, 197, 339, 391, 513, 519, and 639 cm⁻¹ and they confirm the crystalline formation of the anatase TiO₂ [18–20]. Indeed, the sample presented a crystalline structure, with tetragonal anatase as the major phase as follows: three 3E_g nonpolar modes with frequencies 143, 197, and 639 cm⁻¹, 2B_{1g} modes at 391 and 519 cm⁻¹, and 1A_{1g} mode overlaps

with the B_{1g} mode at 519 cm⁻¹ [14–17] at room temperature, but they can be noticeably spectrally separated at sufficiently low temperatures.

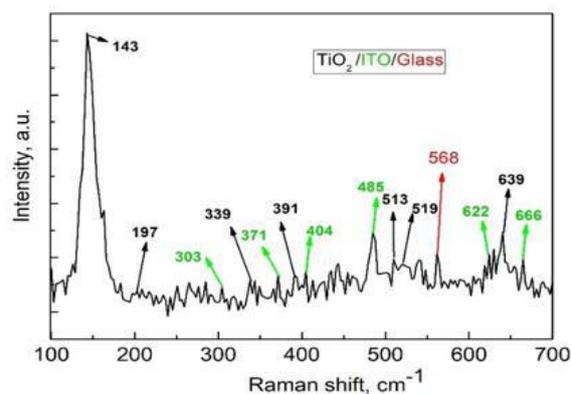


Fig. 4. Raman spectrum of the structure.

Regarding the presence of both brookite and rutile phases in the film, it should be noted that, as has been reported [15] the rutile polymorph phase may exhibit dominant peaks at 446.6 and 609.8 cm⁻¹. However, these modes of rutile haven't been observed in the Raman spectra. Further, as reported in [20], the Raman bands of anatase (399 and 639 cm⁻¹) and brookite (396 and 636 cm⁻¹) are very close in values. Therefore, the existence of two peaks of 391 and 639 cm⁻¹ observed by us initiate a question if they either refer to anatase or brookite. However, the XRD spectrum is given in figure 2, which doesn't have any peaks inherent in brookite, making it possible to completely exclude the presence of the brookite phase in the film. The bands belonging to ITO at the Raman spectrum are 303, 371, 404, 485, and 630 cm⁻¹, whereas the peak at 568 cm⁻¹ are belonging to the glass substrate.

3.4. Optical transmission

The digital images of the samples presented in figure 5 show the change in the appearance of the Ti-coated glass/ITO structure after anodizing, as well as after subsequent thermal annealing. During the anodization process, the initially opaque Ti film (a) gradually transforms into TiO₂ and becomes transparent (b). Upon subsequent thermal annealing at 450°C, the optical transmission and transparency of the samples decrease as compared to non-annealed. This is because, upon annealing in the air, some additional

oxygen vacancies are introduced into the film, on which the light is scattered and the light absorption increases.

Figure 6 shows the optical transmittance of each layer of the glass substrate, *ITO* as well as TiO_2 layer of the Glass/*ITO*/ TiO_2 bilayer structure separately. It can be seen from the spectra that the film is transparent in the region of 900–360nm with a transmittance of about 70–80% and exhibits strong absorption in the UV region with a wavelength shorter than 360nm. The latter is close to the absorption cut-off of bulk titanium dioxide and attributable to the electron's transition from valance to the conduction band of TiO_2 . The wavelength region of 400–750nm showed a few interference fringes which appeared due to multiple reflections at the TiO_2 /*ITO*/glass substrate and the film/air interfaces. The existence of interferometric oscillations is evident in the high optical quality of the *TNT*. A high degree of transmission allows the use of such structures to create *DSSC*.

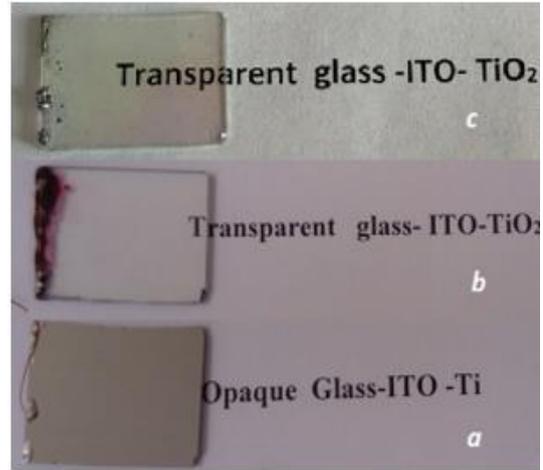


Fig.5. Optical images of the structure before a) and after oxidation (b) and upon annealing (c)

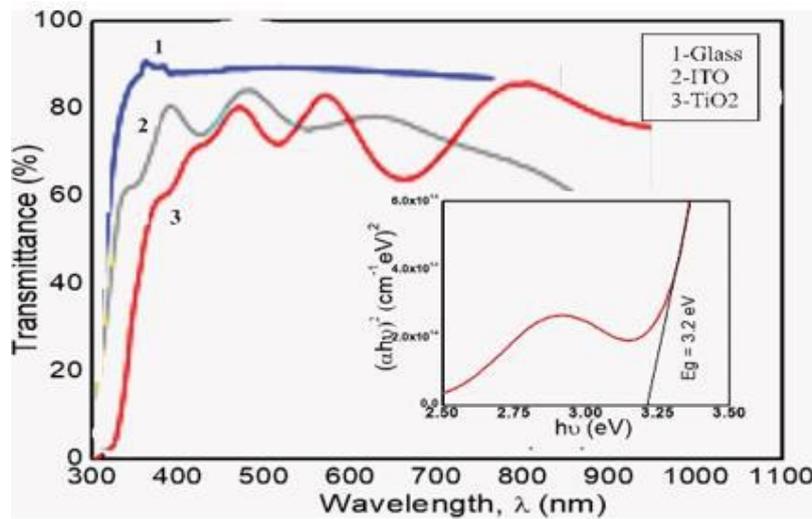


Fig.6. FTIR measurements patterns of Glass/*ITO*/ TiO_2 structure .1- Transmittance spectra of glass substrate, 2- *ITO*, 3- TiO_2 . Inset-band gap of TiO_2

Determination of bandgap energy (E_g) is often necessary to develop the electronic band structure of a thin film material. In the high absorption region, absorption coefficient α is related to the energy $h\nu$ of incident photons by the Tauc's formula $(\alpha h\nu) = A(h\nu - E_g)^n$. Here $h\nu$ is the photon energy, $\alpha = 4\pi k/\lambda$ is the absorption coefficient at wavelength λ , k –extinction coefficient, p is an index that characterizes the optical absorption process and is theoretically equal to 1/2, 2, 3/2 or 3 for direct allowed, indirect allowed, direct forbidden and indirect forbidden transitions, respectively. From the measurements and the plot of the equation, the indirect optical band gap energy, E_g , can be deduced when the linear part of the curve intercepts the x-axis just above the fundamental absorption threshold. An example of the plot of $(\alpha h\nu)^2$ versus photon energy of the films, including extrapolation from the linear curve, is illustrated in the inset of fig. 6. From the plot, it was

determined that the TiO_2 film has a direct bandgap of about 3.20eV.

3.3. Spectroscopic ellipsometry

Ellipsometry is a set of methods for studying the surfaces of liquid and solid bodies by changing the state of polarization of a light beam reflected by this surface and refracted on it. The relationship between the optical constants and the parameters of elliptically polarized light is established on the basis of the Fresnel equations. The ellipsometry actually measures the quantities Δ and Ψ , which describe the change in polarization that occurs when the measurement beam interacts with a sample surface. These angles are defined by the complex ratio $\frac{R_p}{R_s} = \tan(\psi) \exp(i\Delta)$ of Fresnel reflection coefficients for p - and s -polarized light [16-17]. The obtained data is then used to calculate the refraction index and thickness of the layer interacting with the light.

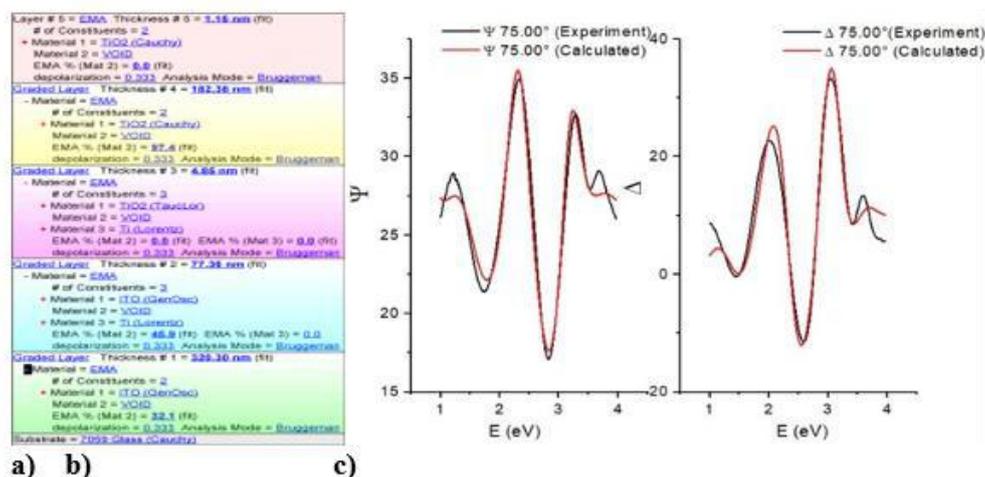


Fig.7. Schematic representation of the proposed physical model of the glass/ITO/TiO₂ structure (a) and illustration of generated and experimental data, curve fitting with the physical model; b) fitting on ψ , c) fitting on Δ at incident angle 75°

The proposed physical model for SE data fitting of the annealed Glass/ITO/TiO₂ thin film structure is presented in Figure 7a, whereas the illustration of the calculated and experimental data, curve-fitted with the appropriated physical model is shown in Figures 6b and 6c. As it can be seen from the model, the multilayer consists of five layers with variable thicknesses and constituents. These can be listed as follows: 1) the glass substrate; 2) the 1st layer (# 320nm, consists of ITO/voids (air)-and Ti); 3) the 2nd (#77nm, ITO/VOID/Ti); 4) the 3rd (# 4.9nm, TiO₂/air /Ti); 5) the 4th (#182nm, TiO₂ /air); 6) the 5th (# 1.15nm, TiO₂/air).

4. CONCLUSION

Radio-frequency magnetron sputtered titanium thin films deposited on Glass/ITO substrates have been anodized and studied. Highly ordered TNT arrays of 40-45nm pore diameter with a high degree of optical transmission were obtained. It has been established that

the surface morphology and structure of nanotubes improve with an increase in the anodization time. Ellipsometry measurements allowed to creation of an optical model of the experimentally fabricated glass/ITO/TiO₂ structure, consisting of five layers with different thicknesses and constituents. The XRD pattern and Raman spectra confirmed the presence of the anatase tetragonal phase of TiO₂ with nanotube arrays. The rutile and brookite phases were not found. By using Tauc's formula it was determined that the TiO₂ film has a direct bandgap of 3.20eV. It was revealed that Glass/ITO/TiO₂ structures are transparent in the region of 900-360nm with a transmittance of about 70– 80% and exhibit strong absorption in the UV region with a wavelength shorter than 360nm. Such a strong absorption of UV of the structure including an external TiO₂ layer with the extended nanotubular surface, as well as an electrically conductive ITO layer, makes it quite suitable for solar energy harvesting application

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